

MOTOROLA
SEMICONDUCTOR
TECHNICAL DATA

Slotted Optical Switches

Logic Output

These devices consist of a GaAs LED facing a silicon, high-speed integrated circuit detector in a molded plastic housing. A slot in the housing between the emitter and the detector provides a means of mechanically interrupting the signal and switching the output from an on-state to an off-state. The detector incorporates a schmitt trigger which provides hysteresis for noise immunity and pulse shaping. The detector circuit is optimized for simplicity of operation and has an open-collector output for application flexibility.

Features:

- Single Unit for Easy PCB Mounting
- Non-Contact Logic Level Switching
- Long-Life Liquid Phase EPI Emitter
- 1 mm Detector Aperture Width
- Suitable for use in 3 V Applications

Applications:

Shaft encoders, non-contact switches, position sensing, paper handlers, coin handlers, and interruptive sensor application requiring logic level outputs.

ABSOLUTE MAXIMUM RATINGS: ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
INPUT LED			
Power Dissipation	P_D	100	mW
Forward Current (Continuous)	I_F	60	mA
Forward Current (Peak) (Pulse Width $\leq 1 \mu\text{s}$, PRR < 300 PPS)	I_F	15	A
Reverse Voltage	V_R	6	V

OUTPUT DETECTOR

Output Voltage Range	V_O	0–16	V
Supply Voltage Range	V_{CC}	3–16	V
Output Current	I_O	50	mA
Power Dissipation	P_D	150*	mW

TOTAL DEVICE

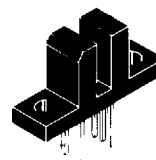
Storage Temperature	T_{stg}	-40°C to 100°C	$^\circ\text{C}$
Operating Temperature	T_J	-40°C to 100°C	$^\circ\text{C}$
Lead Soldering Temperature (5 seconds maximum)	T_L	260	$^\circ\text{C}$

*Derate 2 mW/ $^\circ\text{C}$ above 25°C ambient

MOC75 Series

*MOC75T1 and MOC75U1
are Motorola Preferred Devices

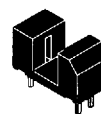
SLOTTED OPTICAL SWITCHES LOGIC OUTPUT



T
CASE 354C-03
STYLE 1



U
CASE 354B-02
STYLE 1



P
CASE 354K-01
STYLE 1

INDIVIDUAL ELECTRICAL CHARACTERISTICS (0–70°C) (See Note 1)

Characteristic	Symbol	Min	Typ	Max	Unit
INPUT LED					
Forward Voltage ($I_F = 20\text{ mA}$)	V_F	—	1.1	1.6	V
Reverse Current ($V_R = 3\text{ V}$)	I_R	—	—	10	μA
Reverse Breakdown Voltage ($I_R = 100\text{ }\mu\text{A}$)	$V_{(BR)R}$	6	—	—	V
Capacitance ($V = 0\text{ V}$, $f = 1\text{ MHz}$)	C	—	24	50	pF
OUTPUT DETECTOR					
Operating Voltage	V_{CC}	3	—	15	V
Supply Current ($I_F = 0$, $V_{CC} = 5\text{ V}$)	$I_{CC(off)}$	—	1.3	5	mA
Output Current, High ($I_F = 0$, $V_{CC} = V_O = 15\text{ V}$)	I_{OH}	—	—	100	μA

COUPLED (0–70°C) (See Note 1)

Threshold Current, ON ($R_L = 270\text{ }\Omega$, $V_{CC} = 5\text{ V}$)	MOC75(T,U,P)1 MOC75(T,U,P)2	$I_{F(on)}$	— —	20 10	30 15	mA
Threshold Current, OFF ($R_L = 270\text{ }\Omega$, $V_{CC} = 5\text{ V}$)	MOC75(T,U,P)1 MOC75(T,U,P)2	$I_{F(off)}$	0.5 0.5	15 8	—	mA
Hysteresis Ratio ($R_L = 270\text{ }\Omega$, $V_{CC} = 5\text{ V}$)		$\frac{I_{F(off)}}{I_{F(on)}}$	—	0.75	—	—
Supply Current ($I_F = I_{F(on)}$, $V_{CC} = 5\text{ V}$)		$I_{CC(on)}$	—	3	5	mA
Output Voltage, Low ($I_F = I_{F(on)}$, $V_{CC} = 5\text{ V}$, $R_L = 270\text{ }\Omega$)		V_{OL}	—	0.2	0.4	V
Turn-On Time	$R_L = 270\text{ }\Omega$, $V_{CC} = 5\text{ V}$, $I_F = I_{F(on)}$, $T_A = 25^\circ\text{C}$	t_{on}	—	1.2	—	μs
Fall Time		t_f	—	0.1	—	
Turn-Off Time		t_{off}	—	1.2	—	
Rise Time		t_r	—	0.1	—	

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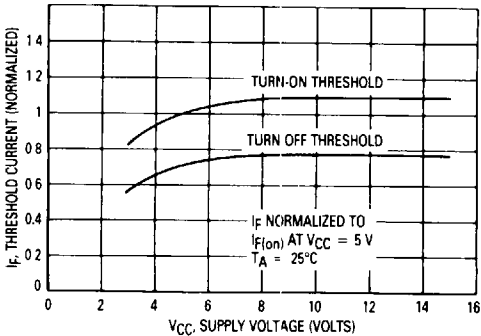


Figure 1. Normalized Threshold Current versus Supply Voltage

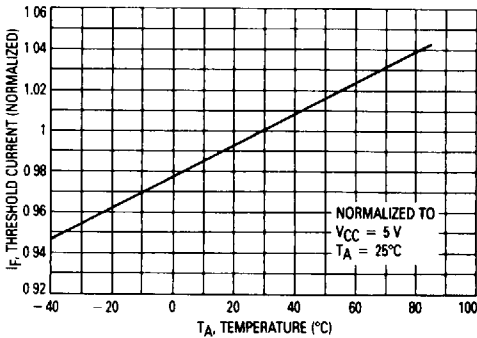


Figure 2. Threshold Current versus Temperature

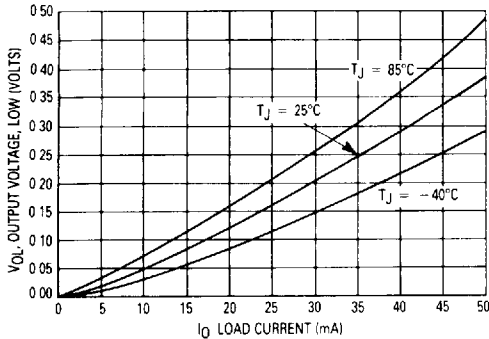


Figure 3. Output Voltage versus Load Current

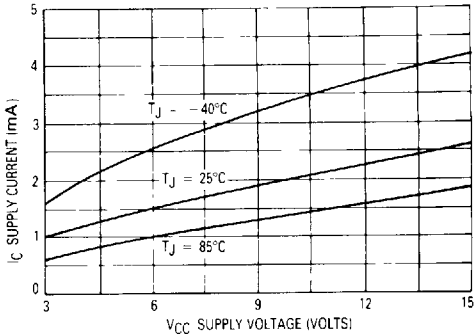


Figure 4. Supply Current versus Supply Voltage — Output High

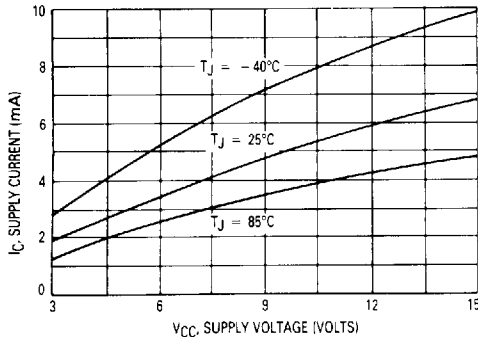


Figure 5. Supply Current versus Supply Voltage — Output Low

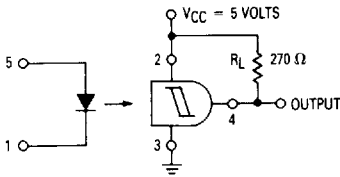


Figure 6. Test Circuit for Threshold Current Measurements

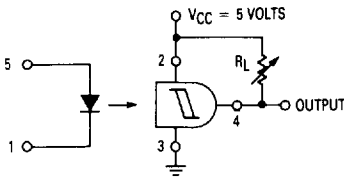


Figure 7. Test Circuit for Output Voltage versus Load Current Measurements

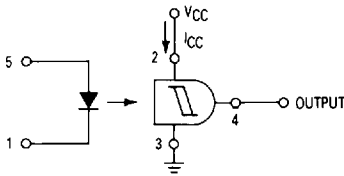


Figure 8. Test Circuit for Supply Current versus Supply Voltage Measurements

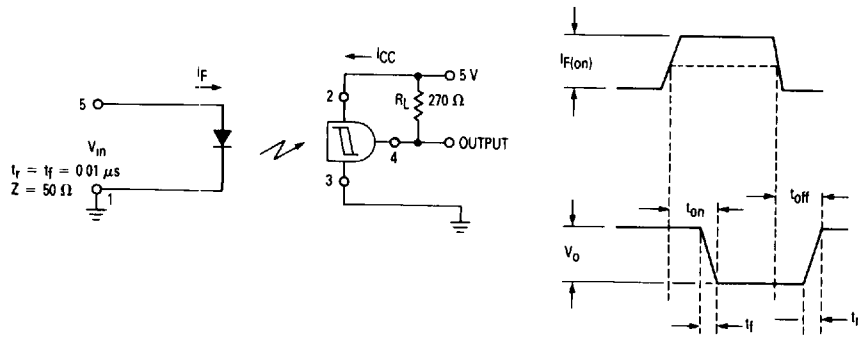


Figure 9. Switching Test Circuit